

Notice of References Cited

Application/Control No.

10/598,971

Applicant(s)/Patent Under
Reexamination
OSHIYAMA ET AL.

Examiner

Vu Nguyen

Art Unit

1796

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0068526 A1	04-2003	Kamatani et al.	428/690
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NON-PATENT DOCUMENTS

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